Notice of References Cited Application/Control No. 10/594,529 Examiner QUEENIE DEHGHAN Applicant(s)/Patent Under Reexamination OTOSAKA, TETSUYA Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0162363	11-2002	Wada et al.	65/414
	В	US-			
	O	US-			
	ם	US-			
	Е	US-			
	F	US-			
	O	US-			
	Ι	US-		1	
	ı	US-			
	٦	US-			
	K	US-	1		
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	σ					
4	R					
	S					
	_				1 C.	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.